# **SPECIFICATION**

SPEC. No. 13a

D A T E: 2013 Feb.

# **Non-Controlled Copy**

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS

CGA Series / Automotive Grade

General (Up to 50V)

Mid voltage (100 to 630V)

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

### RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation
Sales
Electronic Components
Sales & Marketing Group

TDK-EPC Corporation

Engineering

Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

### 1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A. Inc.

### **EXPLANATORY NOTE:**

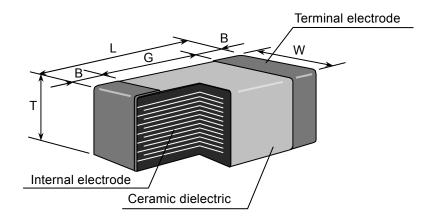
This specification warrant the quality of the ceramic chip capacitor. The chips should be evaluated or confirmed a state of mounted on your product.

If the use of the chips go beyond the bounds of this specification, we can not afford to guarantee.

### 2. CODE CONSTRUCTION

(Example) 
$$\frac{\text{CGA4}}{(1)}$$
  $\frac{\text{J}}{(2)}$   $\frac{3}{(3)}$   $\frac{\text{X7R}}{(4)}$   $\frac{1 \text{ C}}{(5)}$   $\frac{225}{(6)}$   $\frac{\text{K}}{(7)}$   $\frac{\text{T}}{(8)}$ 

### (1) Type



Please refer to product list for the dimension of each product.

### (2) Thickness

\* As for dimension tolerance, please contact with our sales representative.

Thickness	Demension(mm)
Α	0.30
В	0.50
С	0.60
Е	0.80
F	0.85
Н	1.15
J	1.25
K	1.30
L	1.60
М	2.00
N	2.30
Р	2.50
Q	2.80
R	3.20



(3) Voltage condition in the life test (Max. operating Temp./1000h)

Sign	Condition
1	Rated Voltage x 1
2	Rated Voltage x 2
3	Rated Voltage x 1.5
4	Rated Voltage x 1.2

(4) Temperature Characteristics (Details are shown in table 1 No.7 at page 4 and No.8 at page 5)

(5) Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 E	DC 250 V
2 A	DC 100 V
1 H	DC 50 V
1 V	DC 35 V
1 E	DC 25 V
1 C	DC 16 V
1 A	DC 10 V
0 J	DC 6.3 V

### (6) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 2R2 → 2.2pF

 $225 \rightarrow 2,200,000pF$ 

(7) Capacitance tolerance

Symbol	Tolerance	Capacitance
С	± 0.25 pF	10nE and under
D	± 0.5 pF	10pF and under
J	± 5%	
K	± 10 %	Over 10pF
М	± 20 %	

(8) Packaging (Bulk is not applicable for CGA1 and CGA2 type.)

Symbol	Packaging
В	Bulk
T	Taping



### 3. RATED CAPACITANCE AND TOLERANCE

### 3.1 Standard combination of rated capacitance and tolerances

Class	Temperature Characteristics	Capacitar	nce tolerance	Rated capacitance				
1	C0G	10pF and	C (±0.25pF)	1, 1.5, 2, 2.2, 3, 3.3, 4, 4.7, 5				
		under	D (±0.5pF)	6, 6.8, 7, 8, 9, 10				
		COG	COG	COG	COG	12pF to 10,000pF	J (± 5 %) K (± 10 %)	E – 12 series
							Over 10,000pF	K (± 10 %)
2	X7R X7S	10uF and under	K (± 10 %)	E – 6 series				
		_	Over 10uF	M (± 20 %)				

### 3.2 Capacitance Step in E series

E series		Capacitance Step										
E- 6	1	1.0 1.5 2.2 3.3 4.7 6.8						.8				
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

### 4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X5R	-55°C	85°C	25°C
C0G X7R X7S X7T	-55°C	125°C	25°C

### 5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

### 6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as CGA6, CGA8 and CGA9 types are more likely to be affected by heat stress from the substrate.

Please inquire separate specification for the large case sizes when mounted on the substrate.

### 7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

### 8. PERFORMANCE

### table 1

No.	Item	Perfor	mance		Test or inspe	ction method	
1	External Appearance	No defects which performance.		Inspect v	vith magnifyir	ng glass (3×), in case	
2	Insulation Resistance	10,000MΩ or 5000 (As for the capacity voltage 16V DC a 10,000 MΩ or 1000 whichever smaller	tors of rated nd the item below, MΩ·μF min.,)	of CGA1 type, with magnifying glass (10×)  Apply rated voltage for 60s.  As for the rated voltage 630V DC, apply 500V.			
3	Voltage Proof	Withstand test vol insulation breakdo damage.	1 to 5s.	discharge cu	er 3 × rated voltage  1.5 × rated voltage		
4	Capacitance	Within the specifie	measurir	Over 1000pF  10uF and under  Over 10uF  mation which	Measuring frequency voltage  1MHz±10%  1kHz±10%  1kHz±10%  1.0±0.2Vms 0.5±0.2Vms.  120Hz±20% 0.5±0.2Vms.  product has which ease contact with our		
6	Q (Class1)  Dissipation Factor (Class2)	Capacitance  30pF and over  Under 30pF  C: Rated capacita  0.025 max.  0.03 max.  0.05 max.  0.075 max.  0.1 max.	See No.4 condition For informeasurir	i. 4 in this table i. mation which	for measuring  for measuring  product has which ease contact with our		
7	Temperature Characteristics of Capacitance (Class1)	T.C. Tempera  COG 0 ± 3  Capacitance drift v  ± 0.05pF, whichev	Tempera based or temperat Measurir	n values at 25 cure.	nt shall be calculated °C and 85°C re below 20°C shall		



No.	Item	Performance	Test or inspection method			
8	Temperature Characteristics	Capacitance Change (%)	Capacitance shall be measured by the steps shown in the following table after			
	of Capacitance (Class2)	No voltage applied	thermal equilibrium is obtained for each step.			
		X5R : ± 15 X7R : ± 15	ΔC be calculated ref. STEP3 reading			
		X7S: ± 22	Step Temperature(°C)			
		X7T : +22 -33	1 Reference temp. ± 2			
			2 Min. operating temp. ± 3			
			3 Reference temp. ± 2			
			4 Max. operating temp. ± 2			
			Measuring voltage: 0.1, 0.2, 0.5, 1.0Vrr For information which product has which Measuring voltage, please contact with c sales representative.			
9	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b and apply a pushing forc 17.7N with 10±1s. (2N is applied for CGA1, CGA2 type)  Pushing force  Capacitor  P.C.Board			
10	Bending	No mechanical damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2a or Appendix 2b and bend it for 2mm. (1mm is applied for 0.85mm thickness of Clas items.)			
			50 F R230 (Unit : m			

No.		em		Perfor	mance	Test or inspection method		
11			termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material.  A section		oin holes or rough ncentrated in one of A sections osed due to ng of termination	Completely soak both terminations in solder at 235±5°C for 2±0.5s.  Solder: H63A (JIS Z 3282)  Flux: Isopropyl alcohol (JIS K 8839)    Rosin(JIS K 5902) 25% solid solution.		
12	Resistance to solder heat	External appearance	No cracks are allowed and terminations shall be covered at least 60% with new solder.		II be covered at	Completely soak both terminations in solder at 260±5°C for 5±1s.  Preheating condition		
		Capacitance				Temp.: 150±10°C		
			Cha	Characteristics Change from the value before test		Change from the value before test	Time : 1 to 2min.	
			Class1		Capacitance drift within ± 2.5% or ± 0.25pF, whichever larger.	Flux : Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.		
			Class2	X5R X7R X7S X7T	± 7.5 %	Solder: H63A (JIS Z 3282)  Leave the capacitors in ambient		
		Q				condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.		
		(Class1)	Capaci	tance	Q	,		
			30pF a	nd over	1,000 min.			
			Under	30pF	400+20×C min.			
			C : Rate	d capac	itance (pF)			
		D.F. (Class2)	Meet the	initial s	pec.			
		Insulation Resistance	Meet the	initial s	pec.			
		Voltage proof	No insula other dar		eakdown or			

No.	Ite	em	Performance				Test or inspection method		
13	Vibration	External appearance	No mechanical damage.			P.C.Bo	Reflow solder the capacitors on a P.C.Board shown in Appendix1 before testing.  Vibrate the capacitor with following		
		Capacitance	Characteristics Change from the value before test						
			Class1	COG	Capacitance drift within ± 2.5% or ± 0.25pF, whichever larger.	Applie	conditions.  Applied force: 5G max. Frequency: 10-2000Hz Duration: 20 min. Cycle: 12 cycles in each 3 mutually perpendicular directions.		
			Class2	X5R X7R X7S X7T	± 7.5 %	Durati Cycle			
		Q	Capaci	itanco	Q				
		(Class1)		ind over	<del> </del>				
			Under		400+20×C min.				
			C : Rated capacitance (pF)						
		D.F. (Class2)	Meet the initial spec.						
14	Temperature cycle	External appearance	No mechanical damage.			P.C.Bo	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.		
		Capacitance	Charact	teristics	Change from the value before test	Expos step1	Expose the capacitors in the condition step1 through step 4 and repeat 1,00		
			Class1	COG	Capacitance drift within ± 2.5% or ± 0.25pF, whichever larger.	condition for 6 to	the capacitors in amb	tors in ambient 24h (Class 1) or	
			Class2	X5R X7R X7S X7T	± 7.5 %	Step	(Class 2) before mea	Time (min.	
		Q				1	Min. operating temp. ±3	30 ± 3	
		(Class1)		itance ind over	1,000 min.	2	Reference Temp. ±2	2 - 5	
					400+20×C min.	3	Max. operating	30 ± 2	
			Under 30pF 400+20×C min.  C: Rated capacitance (pF)			temp. ±2	30 ± 2		
		D.F. (Class2)	Meet the	•	.,	4	Reference Temp. ±2	2 - 5	
		Insulation Resistance	Meet the	initial	spec.				
		Voltage proof	No insula		eakdown or				

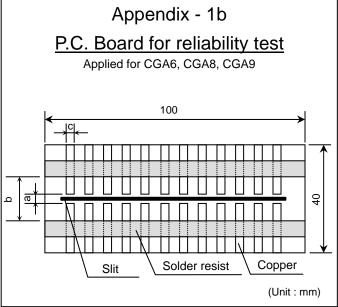
No.			Performance			Test or inspection method						
15	Moisture Resistance	External appearance	No mech	anical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or						
	(Steady State)	Capacitance	Charact	eristics	Change from the	Appendix 1b before testing.						
	State)		Class1	COG	value before test  Capacitance drift within ± 7.5% or ± 0.75pF, whichever larger.	Leave at temperature 40±2°C, 90 to 95%RH for 500 +24,0h.						
			Class2	X5R X7R X7S X7T	± 12.5 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.						
		Q (Class1)	Capac	itance	Q							
		(Class1)	30pF ar	nd over	350 min.							
			10pF ar under		275+5/2×C min.							
			Under	10pF	200+10×C min.							
				•	citance (pF)							
		D.F. (Class2)	Characteristics 200% of initial spec. max.									
		Insulation	1,000M $\Omega$ or 50M $\Omega$ ·μF min.									
	Resistance		(As for the capacitors of rated voltage 16V DC and item below, 1,000MΩ or 10MΩ·μF min.,) whichever smaller.									
16	Moisture	External	No mech	anical	damage.	Reflow solder the capacitors on a						
	Resistance	appearance				P.C.Board shown in Appendix 1a or Appendix 1b before testing.						
		Capacitance	Change from the value before test			Apply the rated voltage at temperatu						
										Class1	COG	Capacitance drift within ± 7.5% or ± 0.75pF, whichever larger.
			Class2	X5R X7R X7S X7T	± 12.5 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.						
		Q (Class1)	Capac	itance	Q	Voltage conditioning (only for class 2) Voltage treat the capacitors under						
		(Class1)	30pF ar	nd over	200 and over	testing temperature and voltage for 1						
			Under 30pF   100+10/3×C min.		100+10/3×C min.	hour. Leave the capacitors in ambient						
			C : Rated capacitance (pF)		citance (pF)	condition for 24±2h before						
		D.F. (Class2)	Characte 200% of		spec. max.	measurement. Use this measurement for initial value.						
		Insulation Resistance	(As for th voltage 1	e capa 6V DC 00MΩ (	Ω·μF min. acitors of rated and item or 5ΜΩ·μF min.,) ler.							



(0011	illiueu)					
No.	It	em		Perfo	rmance	Test or inspection method
17	Life	External appearance	No mechanical damage.		damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.
		Capacitance	Charact	eristics	Change from the value before test	Below the voltage shall be applied at
			Class1	COG	Capacitance drift within ± 7.5% or ± 0.75pF,	maximum operating temperature ±2°C for 1,000 +48, 0h.
				Applied voltage		
			Class2	X5R X7R	± 15 %	Rated voltage x2
			Olassz	X7S X7T	10 70	Rated voltage x1.5
		0		•		Rated voltage x1.2
		Q (Class1)	Capacitance 30pF and over 10pF and over to under 30pF		Q	Rated voltage x1
					350 and over	For information which product has which
					275+5/2×C min.	applied voltage, please contact with our sales representative.
			Unde	r 10pF	200+10×C min.	
			C : Rated capacitance (pF)			Charge/discharge current shall not
		D.F. (Class2)	Characteristics 200% of initial spec. max.			exceed 50mA.
		Insulation Resistance	1,000MΩ or 50MΩ·μF min. (As for the capacitors of rated voltage 16V DC and the item below, 1,000 MΩ or 10MΩ·μF min.,) whichever smaller.		icitors of rated C and the item Ω or 10MΩ·μF	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.
						Voltage conditioning (only for class 2) Voltage treat the capacitors under testing temperature and voltage for 1 hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.

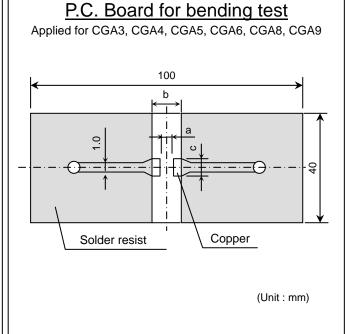
<sup>\*</sup>As for the initial measurement of capacitors (Class2) on number 8,12,13,14 and 15 leave capacitors at 150 –10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.

# Appendix - 1a P.C. Board for reliability test Applied for CGA1, CGA2, CGA3, CGA4, CGA5



Appendix - 2b

# Appendix - 2a P.C. Board for bending test Applied for CGA1, CGA2 Solder resist (Unit : mm) Copper



P.C. Board thickness : Appendix-2a 0.8mm
Appendix-1a, 1b, 2b 1.6mm

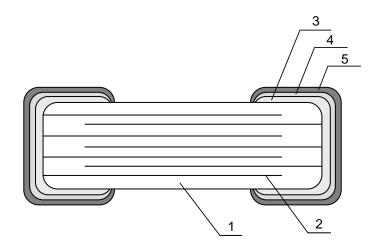
Copper ( thickness 0.035mm )
Solder resist

Material: Glass Epoxy (As per JIS C6484 GE4)

TDK (EIA style)	Dimensions (mm)				
TDR (EIA Style)	а	b	С		
CGA1(CC0201)	0.3	0.8	0.3		
CGA2(CC0402)	0.4	1.5	0.5		
CGA3(CC0603)	1.0	3.0	1.2		
CGA4(CC0805)	1.2	4.0	1.65		
CGA5(CC1206)	2.2	5.0	2.0		
CGA6(CC1210)	2.2	5.0	2.9		
CGA8(CC1812)	3.5	7.0	3.7		
CGA9(CC2220)	4.5	8.0	5.6		
· · · · · · · · · · · · · · · · · · ·					



### 9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL				
NO.	INAIVIE	Class1	Class2			
1	Dielectric	CaZrO₃	BaTiO <sub>3</sub>			
2	Electrode	Nickel (Ni)				
3		Copper (Cu)				
4	Termination	Nickel (Ni)				
5		Tin (Sn)				

### 10. RECOMMENDATION

As for CGA6(CC1210), CGA8(CC1812) and CGA9(CC2220) types, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

### 11. SOLDERING CONDITION

As for CGA1(CC0201), CGA2(CC0402), CGA6(CC1210) , CGA8(CC1812) and CGA9(CC2220) types, reflow soldering only.



### 12. Caution

-		O an altition					
No.	Process	Condition					
1	Operating Condition (Storage,	<ul> <li>1-1. Storage</li> <li>1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.</li> </ul>					
	Transportation)	2) The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur.					
		3) Avoid storing in sun light and falling of dew.					
		4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.					
		5) Capacitors should be tested for the solderability when they are stored for long time.					
		1-2. Handling in transportation					
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation)					
2	Circuit design  Laution	2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.					
		Do not use capacitors above the maximum allowable operating temperature.					
		2) Surface temperature including self heating should be below maximum operating temperature.					
		(Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at					
		high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum					
		temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be					
		below 20°C)					
		3) The electrical characteristics of the capacitors will vary depending on the					
		temperature. The capacitors should be selected and designed in taking the temperature into consideration.					
		2-2. Operating voltage					
		1) Operating voltage across the terminals should be below the rated voltage.  When AC and DC are super imposed, V <sub>0-P</sub> must be below the rated voltage.					
		AC or pulse with overshooting, $V_{P-P}$ must be below the rated voltage.					
		When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.					
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage					
		Positional					
		Measurement $ \mathbf{V}_{0-P} $ $ \mathbf{V}_{0-P} $					
		(Rated voltage) 0 0					
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)					
		Positional					
		Measurement   V <sub>P-P</sub>					
		(Rated voltage)					

No.	Process			Condition				
2	Circuit design	2) Even below the reliability of	he rated voltage of the capacitors	e, if repetitive h	•	equency AC	or pul	se is applied,
	Z: \ Caulion	The capacito	3) The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.					
			pacitors (Class ay vibrate them					s, the
3	Designing P.C.board	capacitors.  1) The greater the and the more shape and size terminations.  2) Avoid using contacts.	The greater the amount of solder, the higher the stress on the chip capacitors and the more likely that it will break. When designing a P.C.board, determine shape and size of the solder lands to have proper amount of solder on the					
		3) Size and reco						
		)		Chip capacitors	0.1			
			<i></i>	_ / _	Soli  -	der land		
		C Solder resist						resist
			В	A		<i></i>		
		Flow solder		<u> </u>		1	(mm)	
		Type Symbol	CGA3 (CC0603)	CGA4 (CC080		CGA5 (CC120		
		A	0.7 - 1.0	1.0 - 1.0	3	2.1 - 2	.5	
		В	0.8 - 1.0	1.0 - 1.2	2	1.1 - 1	.3	
		C	0.6 - 0.8	0.8 - 1.	1	1.0 - 1	.3	
		Reflow sold	ering					(mm)
		Type Symbol	CGA1 (CC0201)	CGA2 (CC0402)	((	CGA3 CC0603)		GA4 (0805)
		A	0.25 - 0.35	0.3 - 0.5		0.6 - 0.8		) - 1.2
		В	0.2 - 0.3	0.35 - 0.45	(	0.6 - 0.8	0.7	- 0.9
		C 0.25 - 0.35 0.4 - 0.6 0.6 - 0.8 0.9 - 1.2						- 1.2
		Type CGA5 CGA6 CGA8 CGA9						 GA9
		Symbol	(CC1206)	(CC1210)	((	CC1812)		2220)
		A	2.0 - 2.4	2.0 - 2.4	1	3.1 - 3.7		- 4.8
		B	1.0 - 1.2	1.0 - 1.2	1	1.2 - 1.4		- 1.4
		C	1.1 - 1.6	1.9 - 2.5	2	2.4 - 3.2	4.0	- 5.0
		J						

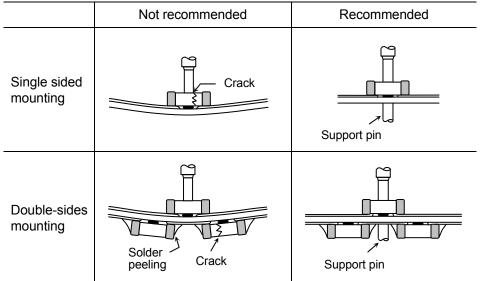
NI-	December		Condition						
No. 3	Process  Designing P.C.board	4) Recommended	Recommended chip capacitors layout is as following.						
	1.0.00010		Disadvantage against bending stress	Advantage against bending stress					
		Mounting face	Perforation or slit  Break P.C.board with	Perforation or slit  Break P.C.board with					
			mounted side up.	mounted side down.					
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit  Perforation or slit	Mount in parallel with perforation or slit  Perforation or slit					
		Distance from slit	Closer to slit is higher stress $\ell_1 \qquad \qquad \ell_1 \qquad \qquad (\ell_1 < \ell_2  )$	Away from slit is less stress  (\ell_1 < \ell_2)					

Condition No. **Process** 3 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. Designing P.C.board E Perforation 00000 00000 В Slit The stress in capacitors is in the following order. A > B = C > D > E6) Layout recommendation Use of common Use of common Soldering with Example solder land with solder land chassis other SMD Lead wire Chassis Solder Excessive solder chip Solder Need to avoid Excessive solder PCB Adhesive Solder land Missing Solder land solder Lead wire Solder resist Solder resist Recommendation Solder resist



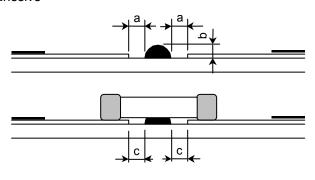
 $\ell^2 > \ell^1$ 

No.	Process		Condition				
4	Mounting	capacitors to res  1) Adjust the botto surface and no  2) Adjust the mou  3) To minimize the	nead is adjusted too low, it may in ult in cracking. Please take following medical center of the mounting heat press it.  Inting head pressure to be 1 to 3N is impact energy from mounting heat is bottom side of the P.C.board.	ead to reach on the P.C.board of static weight.			
			Not recommended	Recommended			
			<u> </u>				



When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.

### 4-2. Amount of adhesive



Example: CGA4 (CC0805), CGA5 (CC1206)

а	0.2mm min.
b	70 - 100μm
С	Do not touch the solder land

No.	Process		Co	ondition				
5	Soldering	5-1. Flux selection Although highly-activat activity may also degra degradation, it is recom  1) It is recommended to Strong flux is not recommended.	nde the insulation nmended following ouse a mildly acommended. one avoided. Plea	n of the chip cang.  ctivated rosin for the second control of the cange of the cang	pacitors. To avoid	oid such .1wt% chlorine).		
		3) When water-soluble f	Tux is used, eno	ugn wasning is	necessary.			
		5-2. Recommended soldering profile by various methods  Wave soldering  Soldering  Soldering						
		Preheating	Natural cooling	<b>→</b>     <del>←</del>	Preheating	Natural cooling		
		Peak Temp  Over 60 sec.  Peak Temp  Over 60 sec.	Over 60 sec.	Peak Temp (O) Ove	r 60 sec.	Temp time		
		Manual soldering						
	(Solder iron)  As for C  CGA5 (c  and refle  As for C  CGA6 (c)				CGA3 (CC0603), C (CC1206), applied iflow soldering. CGA1 (CC0201), C (CC1210), CGA8 ( (CC2220) applied	CGA2 (CC0402), CC1812),		
		5-3. Recommended sold	ering peak temp	and peak tem	p duration			
		Temp./Duration	Wave so	oldering	Reflow so	oldering		
		Solder	Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)		
		Pb-Sn Solder	250 max.	3 max.	230 max.	20 max.		
		Lead Free Solder	260 max.	5 max.	260 max.	10 max.		
		Recommended solde Sn-37Pb (Pb-Sn sol Sn-3.0Ag-0.5Cu (Le	lder)					

No.	Process	Condition
5	Soldering	5-4. Avoiding thermal shock
		1) Preheating condition
		Soldering Type Temp. (°C)
		CGA3(CC0603), CGA4(CC0805),   ΔT ≤ 150
		CGA1(CC0201), CGA2(CC0402), $ CGA3(CC0603), CGA4(CC0805), \qquad \Delta T \leq 150 $ $ CGA5(CC1206) $
		CGA6(CC1210), CGA8(1812), CGA9(CC2220) ΔT ≤ 130
		CGA1(CC0201), CGA2(CC0402),
		CGA6(CC1210), CGA8(1812), CGA9(CC2220) ΔT ≤ 130
		5-5. Amount of solder  Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.  Excessive solder  Higher tensile force in chip capacitors to cause
		Adequate Maximum amount Minimum amount
		Insufficient solder  Low robustness may cause contact failure or chip capacitors come off the P.C.board.
		<ul> <li>5-6. Solder repair by solder iron</li> <li>1) Selection of the soldering iron tip  Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However, heat shock may cause a crack in the chip capacitors.  Please make sure the tip temp. before soldering and keep the peak temp and time in accordance with following recommended condition. (Please preheat the chip capacitors with the condition in 5-4 to avoid the thermal shock.)</li> </ul>

No.	Process		Cond	ition				
5	Soldering	Recommended sold	er iron condition (F	Pb-Sn Solder and	Lead Free Solder)			
		Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)			
		300 max.	3 max.	20 max.	Ø 3.0 max.			
		Direct contact of the may cause crack. Do solder iron.	_					
		5-7. Sn-Zn solder Sn-Zn solder affects pro Please contact TDK in a		ze Sn-Zn solder.				
		5-8. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335B Annex A (Informative) Recommendations to prevent the tombstone phenomenon)						
6	Cleaning	<ol> <li>If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.</li> <li>If cleaning condition is not suitable, it may damage the chip capacitors.</li> </ol>						
		<ul><li>2)-1. Insufficient washing</li><li>(1) Terminal electrodes may corrode by Halogen in the flux.</li><li>(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.</li></ul>						
		(3) Water soluble flux has higher tendency to have above m problems (1) and (2).						
		2)-2. Excessive washing						
		When ultrasonic cleaning is used, excessively high ultrasonic ene can affect the connection between the ceramic chip capacitor's b terminal electrode. To avoid this, following is the recommended c						
			Power: 20 W/l r Frequency: 40 k Washing time: 5	Hz max.				
		2)-3. If the cleaning fluid is bring the same result			ncreases, and it may			

No.	Process		Condition	
7	Coating and molding of the P.C.board	2) Please vo emission	P.C.board is coated, please verify the carefully that there is no harduring curing which may damage the curing temperature.	rmful decomposing or reaction gas
8	Handling after chip mounted	2) When fur to be adjusted bence	the chip capacitors may crack.  Bend  nctional check of the P.C.board is plusted higher for fear of loose contains.	Twist  Terrormed, check pin pressure tends act. But if the pressure is excessive p capacitors or peel the terminations the P.C.board.
		Board bending	Not recommended  Termination peeling  Check pin	Support pin Check pin
9	Handling of loose chip capacitors	the large of handle with the large of handle w	case sized chip capacitors are tenderth care.	ce dropped do not use it. Especially, ency to have cracks easily, so please  — Crack  — Crack  — coard to cause crack.

No.	Process	Condition
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.
12	Others A Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.  The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.  (1) Aerospace/Aviation equipment (2) Transportation equipment (cars, electric trains, ships, etc.) (3) Medical equipment (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications.  When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.



### 13. PACKAGING LABEL

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

\*Composition of Inspection No.

Example 
$$\underline{F}$$
  $\underline{2}$   $\underline{A}$  -  $\underline{OO}$  -  $\underline{OOO}$  (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

### 14. BULK PACKAGING QUANTITY

Total number of components in a plastic bag for bulk packaging : 1,000pcs. As for CGA1, CGA2 types, not available for bulk packaging.



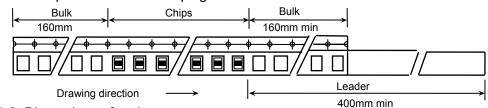
### 15. TAPE PACKAGING SPECIFICATION

### 1. CONSTRUCTION AND DIMENSION OF TAPING

### 1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4, 5. Dimensions of plastic tape shall be according to Appendix 6, 7.

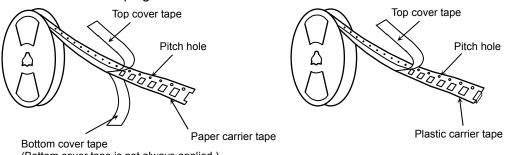
### 1-2. Bulk part and leader of taping



### 1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 8, 9. Dimensions of Ø330 reel shall be according to Appendix 10, 11.

### 1-4. Structure of taping



### (Bottom cover tape is not always applied.)

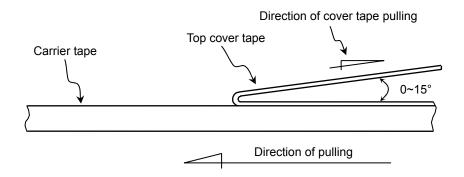
### 2. CHIP QUANTITY

Typo	Thickness	Taping	Chip qua	ntity(pcs.)	
Туре	of chip Material		Ø 178mm reel	Ø 330mm reel	
CGA1(CC0201)	0.30 mm	Paper	15,000	-	
CGA2(CC0402)	0.50 mm	Paper	10,000	50,000	
CGA3(CC0603)	0.80 mm	Paper/ Plastic	4,000	10,000	
	0.60mm	Paper	4,000	20,000	
CGA4(CC0805)	0.85 mm	Paper	4,000	10,000	
	1.25 mm	Plastic	2,000	10,000	
	0.60 mm	Paper	4,000		
	0.85 mm	i apei	4,000	10,000	
CGA5(CC1206)	1.15 mm				
	1.30 mm	Plastic	2,000		
	1.60 mm			8,000	
CGA6(CC1210)	1.25 mm		2,000	8,000	
	1.60 mm		2,000	0,000	
	2.00 mm	Plastic			
	2.30 mm		1,000	5,000	
	2.50 mm				
	1.60 mm		1,000		
	2.00 mm		1,000	3,000	
CGA8(CC1812)	2.30 mm	Plastic		3,000	
CGA0(CC1012)	2.50 mm	Flastic	500		
	2.80 mm		500	2,000	
	3.20 mm			2,000	
	1.60 mm		1,000		
CGA9(CC2220)	2.00 mm	Plastic		3,000	
OGA3(OO2220)	2.30 mm	Flastic	500	3,000	
-	2.50 mm				

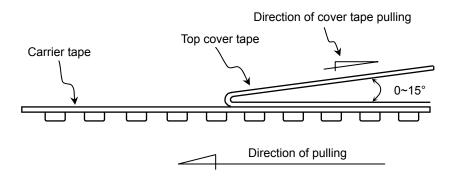
### 3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05-0.7N. (See the following figure.)

TYPE 1 (Paper)



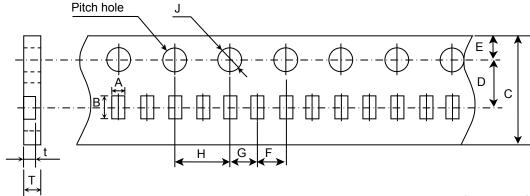
TYPE 2 (Plastic)



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.



### Paper Tape



(Unit: mm)

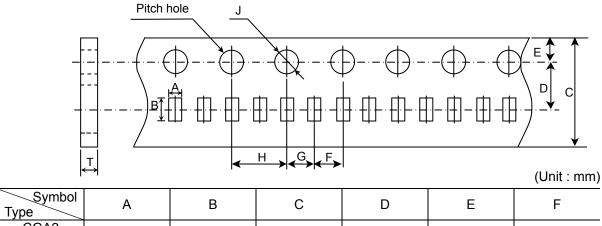
 $2.00 \pm 0.05$ 

Symbol Type	Α	В	С	D	E	F
CGA1 (CC0201)	(0.38)	( 0.68 )	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05
Symbol Type	G	Н	J	t	Т	-
CGA1	2.00 ± 0.05	4.00 ± 0.05	Ø 1.5 +0.10	0.35 ± 0.02	0.40 min.	

<sup>\*</sup> The values in the parentheses ( ) are for reference.

### **Appendix 4**

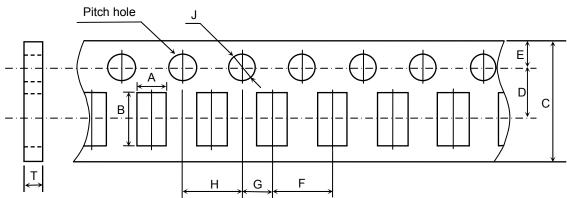
### Paper Tape



-71					
CGA2 (CC0402)	( 0.65 )	(1.15)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10
Symbol Type	G	Н	J	Т	
CGA2 (CC0402)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	0.60 ± 0.05	

<sup>\*</sup> The values in the parentheses ( ) are for reference

# Paper Tape



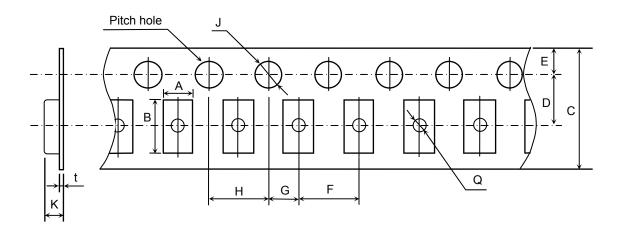
(Unit: mm)

Symbol Type	Α	В	С	D	E	F
CGA3 (CC0603)	( 1.10 )	(1.90)				
CGA4 (CC0805)	( 1.50 )	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
CGA5 (CC1206)	( 1.90 )	(3.50)				

Symbol Type	G	Н	J	Т
CGA3 (CC0603) CGA4 (CC0805) CGA5 (CC1206)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 <sup>+0.10</sup>	1.20 max.

 $<sup>^{\</sup>star}$  The values in the parentheses (  $\,$  ) are for reference.

### Plastic Tape



(Unit:mm)

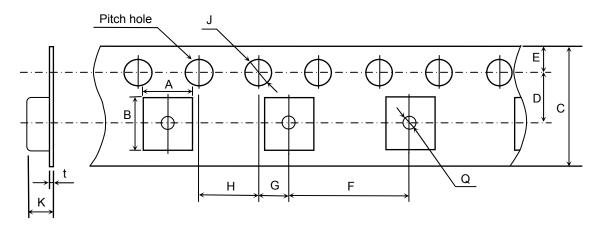
Symbol Type	А	В	С	D	E	F
CGA3 (CC0603)	( 1.10 )	(1.90)				
CGA4 (CC0805)	( 1.50 )	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
CGA5 (CC1206)	( 1.90 )	(3.50)	[12.0 ± 0.30]	[5.50 ± 0.05]	1.73 ± 0.10	4.00 1 0.10
CGA6 (CC1210)	( 2.90 )	(3.60)				
			1			
Symbol Type	G	Н	J	К	t	Q
	G	Н	J	1.50 max.	t	Q
Type CGA3			10.10	1.50 max.	0.30 max.	
Type CGA3 (CC0603) CGA4	G 2.00 ± 0.05	H 4.00 ± 0.10			-	Q Ø 0.50 min.

 $<sup>^{\</sup>star}$  The values in the parentheses (  $\,\,$  ) are for reference.



<sup>\*</sup> As for 2.5mm thickness products, apply values in the brackets [ ].

### Plastic Tape

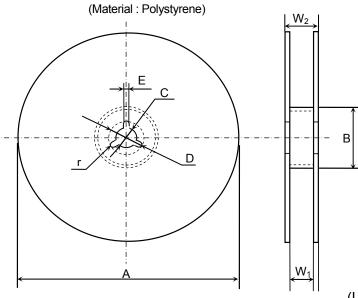


(Unit:mm)

Symbol Type	А	В	С	D	E	F
CGA8 (CC1812)	(3.60)	(4.90)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
CGA9 (CC2220)	(5.40)	(6.10)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	6.00 ± 0.10
Symbol Type	G	Н	J	К	t	Q
CGA8 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	6.50 max.	0.60 max.	Ø 1.50 min.
CGA9	1 Z.UU I U.US	1 4.00 £ 0.10	0 1.5	0.50 max.	0.00 max.	ווווו טפ.ז ש

<sup>\*</sup> The values in the parentheses ( ) are for reference.

CGA1, CGA2, CGA3, CGA4, CGA5, CGA6 ( As for CGA6 type, any thickness of the item except 2.5mm )



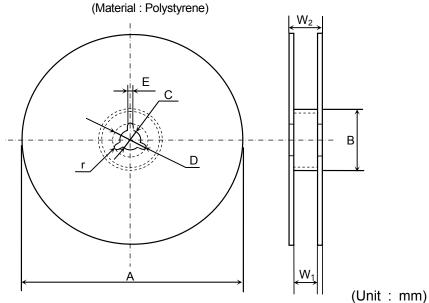
(Unit: mm)

Symbol	Α	В	С	D	Е	$W_1$
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	$W_2$	r
Dimension	13.0 ± 1.4	1.0

### **Appendix 9**

CGA6 (Applied to 2.5mm thickness products), CGA8, CGA9

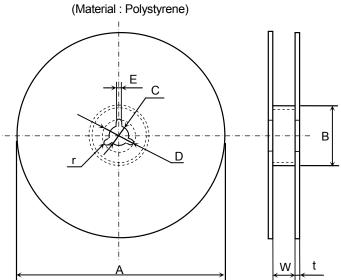


					`	
Symbol	Α	В	С	D	Е	$W_1$
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3

Symbol	$W_2$	r
Dimension	17.0 ± 1.4	1.0



CGA1, CGA2, CGA3, CGA4, CGA5, CGA6 ( As for CGA6 type, any thickness of the item except 2.5 mm )



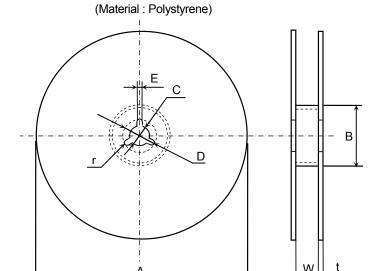
(Unit	:	mm)

Symbol	Α	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	r
Dimension	$2.0 \pm 0.5$	1.0

### **Appendix 11**

CGA6 (Applied to 2.5mm thickness products), CGA8, CGA9



			7.	<b>─</b>	$\longrightarrow \parallel \leftarrow$	(Unit:mm)
Symbol	Α	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0

